

Search Notes

Application/Control No.

10/500,860

Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

SHIMIZU ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	660	7/05	hnh
439	74		
439	736		
29	876		
29	883		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Plus Search Done	7/05	hnh
29/837 & 842 Cursory		
Text Search Done		
Consulted with Exmr Arbes in class 29		